



EMC COMPLIANCE TEST REPORT

for

PENTIUM EBX SBC

Trade Name : ADVANTECH
Model Number : PCM-9550F-A0A1, PCM-9550F-F0A1
Serial Number : N/A
Report Number : 000381-E
Date : August 31, 2000
Regulations : See below

Standards	Results (Pass/Fail)
EN 55022: 1994 + A1: 1995 + A2: 1997 (Class A)	PASS
EN 61000-3-2: 1995 + A1: 1998 + A2: 1998	PASS
EN 61000-3-3:1995	PASS
EN 50082-2: 1995	PASS
- EN 61000-4-2: 1995	PASS
- ENV 50140: 1994	PASS
- ENV 50204: 1996	PASS
- EN 61000-4-4:1995	PASS
- ENV 50141: 1994	PASS

Prepared for :

Advantech Co., Ltd.
4th FL., No. 108-3 Ming-Chuan Road, Hsin-Tien City,
Taipei Hsien, Taiwan, R.O.C.

Prepared by :

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EC-Declaration of Conformity

For the following equipment:

PENTIUM EBX SBC

(Product Name)

PCM-9550F-A0A1, PCM-9550F-F0A1 / ADVANTECH

(Model Designation / Trade name)

Advantech Co., Ltd.

(Manufacturer Name)

4th FL., No. 108-3 Ming-Chuan Road, Hsin-Tien City, Taipei Hsien, Taiwan, R.O.C.

(Manufacturer Address)

is herewith confirmed to comply with the requirements set out in the Council Directive on the Approximation of the Laws of the Member States relating to Electromagnetic Compatibility Directive (89/336/EEC, Amended by 92/31/EEC & 93/68/EEC), For the evaluation regarding the Electromagnetic Compatibility (89/336/EEC, Amended by 92/31/EEC & 93/68/EEC), the following standards are applied:

☒ EN 55022: 1994+A1: 1995+A2: 1997

☒ EN 61000-3-2: 1995 +A1: 1998 + A2: 1998

☒ EN 61000-3-3: 1995

☒ EN 50082-2: 1997

EN 61000-4-2: 1995; ENV 50140: 1994; ENV 50204: 1996; EN 61000-4-4:1995

ENV 50141: 1994

The following manufacturer / importer or authorized representative established within the EUT is responsible for this declaration:

(Company Name)

(Company Address)

Person responsible for making this declaration:

(Name, Surname)

(Position / Title)

(Place)

(Date)

(Legal Signature)

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VERIFICATION OF COMPLIANCE

Equipment Under Test: PENTIUM EBX SBC
Trade Name: ADVANTECH
Model Number: PCM-9550F-A0A1, PCM-9550F-F0A1
Serial Number: N/A
EUT Powered during test: 230VAC/50Hz
Applicant:
Advantech Co., Ltd.
4th FL., No. 108-3 Ming-Chuan Road, Hsin-Tien City,
Taipei Hsien, Taiwan, R.O.C.
Manufacturer:
Advantech Co., Ltd.
4th FL., No. 108-3 Ming-Chuan Road, Hsin-Tien City,
Taipei Hsien, Taiwan, R.O.C.
Type of Test: EMC Directive 89/336/EEC for CE Marking
Technical Standards: EN 55022: 1994+A1: 1995+A2: 1997
EN 61000-3-2: 1995 +A1: 1998 + A2: 1998
EN 61000-3-3: 1995
EN 50082-2: 1997
EN 61000-4-2: 1995; ENV 50140: 1994; ENV 50204: 1996
EN 61000-4-4: 1995; ENV 50141: 1994
File Number: 000381-E
Date of test: July 26, 27 and August 15, 28, 2000
Deviation: According to applicant declaration this EUT is a class A product, and to market in Industrial environment only
Condition of Test Sample: Normal

The above equipment was tested by C&C Laboratory Co., Ltd. for compliance with the requirements set forth in EMC Directive 89/336/EEC and the Technical Standards mentioned above. This said equipment in the configuration described in this report shows the maximum emission levels emanating from equipment and the level of the immunity endurance of the equipment are within the compliance requirements.

The test results of this report relate only to the tested sample identified in this report.

Approved by Authorized Signatory: _____
Kurt Chen / Q.A. Manager

GENERAL INFORMATION

Applicant: **Advantech Co., Ltd.**
4 th FL., No. 108-3 Ming-Chuan Road, Hsin-Tien City,
Taipei Hsien, Taiwan, R.O.C.

Contact Person: John Chou

Manufacturer: **Advantech Co., Ltd.**
4 th FL., No. 108-3 Ming-Chuan Road, Hsin-Tien City,
Taipei Hsien, Taiwan, R.O.C.

File Number: 000381-E

Date of Test: July 26, 27 and August 15, 28, 2000

Equipment Under Test: PENTIUM EBX SBC

Model Number: PCM-9550F-A0A1, PCM-9550F-F0A1

Serial Number: N/A

Technical Standards: EN 55022: 1994+A1: 1995+A2: 1997
EN 61000-3-2: 1995 +A1: 1998 + A2: 1998
EN 61000-3-3: 1995
EN 50082-2: 1997
EN 61000-4-2: 1995; ENV 50140: 1994; ENV 50204: 1996
EN 61000-4-4:1995; ENV 50141: 1994

**Frequency Range
(EN 55022):** 150kHz to 30MHz for Line Conducted Test
30MHz to 1000MHz for Radiated Emission Test

Test Site **C & C LABORATORY CO., LTD.**
No. 15, 14 Lin, Chi Twu Chi, Lu-Chu Hsiang
Taoyuan, Taiwan, R. O. C.

SYSTEM DESCRIPTION

EUT Test Program:

1. Test program was loaded and executed in Windows 98 mode.
2. EUT sends and received from Notebook PC on remote side via an UTP Cable.
3. Data was sent to monitor and filling the screens with upper case of “H” patterns.
4. Test program sequentially exercised all related I/O’s of EUT and sent “H” patterns to all applicable output ports of EUT.
5. Repeat 2 to 4. Test program is self-repeating throughout the test.

PRODUCT INFORMATION

Housing Type:	N/A	
EUT Power Rating:	DCV from Power Supply	
AC Power during Test	230VAC/50Hz to Power Supply	
Power Supply Manufacturer:	ADVANTECH	
Power Supply Model Number:	PS-55A	
AC Power Cord Type:	Unshielded, 1.8m (Detachable) to Power Supply	
CPU Manufacture:	Intel	Type: 1) PENTIUM MMX-166MHz 2) PENTIUM MMX-266MHz
OSC/Clock Frequencies:	66MHz	
Memory Capacity Manufacturer:	NEC	Install: 64 MB
HDD Manufacturer:	IBM	Model: DBCA-203240
VGA Card Type:	On Board	
Chassis Manufacturer:	ADVANTECH	Model: MBPC-300

I/O Port of EUT

I/O PORT TYPES	Q'TY	TESTED WITH
Parallel Port	1	1
Serial Port	4	4
Video Port	1	1
PS/2 Keyboard Port	1	1
PS/2 Mouse	1	1
Microphone Port	1	1
Line-in Port	1	1
Line-out Port	1	1
Speaker-out Port	1	1
LAN Port	1	1
USB Port	2	2

Note: Different between two Model Number are PCM-9550F-A0A1 used MMX-166Hz CPU and PCM-9550F-F0A1 was used MMX-266Hz.

SUPPORT EQUIPMENT

(FOR EN 55022 test only)

No.	Equipment	Model #	Serial #	FCC ID	Trade Name	Data Cable	Power Cord
1.	Monitor	D2835	KR74011499	A3LCGE750	HP	Shielded, 1.8m with two core	Unshielded, 1.8m
2.	Modem	2400	94-364-176270	DK467GSM24	Computer Peripherals	Shielded, 1.8m	Unshielded, 1.8m
3.	Modem	2400SE	94-364-176279	DK467GSM24	Computer Peripherals	Shielded, 1.8m	Unshielded, 1.8m
4.	Modem	2400	94-364-176277	DK467GSM24	Computer Peripherals	Shielded, 1.8m	Unshielded, 1.8m
5.	Printer	C2642A	TH86K1M14P	B94C2642X	HP	Shielded, 1.8m	AC I/P: Unshielded, 0.9m DC OI/P: Unshielded, 1.9m
6.	PS/2 Keyboard	SK-2502C	M99043551	FCC DoC	HP	Shielded, 1.8m	N/A
7.	PS/2 Mouse	M-S43	LZA93405343	DZL211106	Logitech	Shielded, 1.8m	N/A
8.	COM Mouse	M-MM43	LZE94052791	DoC	Logitech	Shielded, 1.8m	N/A
9.	USB Mouse	M-UA34	LTC73700526	DZL211087	HP	Shielded, 1.8m	N/A
10.	USB Mouse	M-UA34	LTC73700535	DZL211087	Logitech	Shielded, 1.8m	N/A
11.	Walkman	YX-328	W2	N/A	YING-KO	Unshielded, 1.8m	N/A
12.	Multimedia Headset	SX-M	A5-4	N/A	TOKYO	Unshielded, 1.8m	N/A
13.	Speaker	P-9A	E7	N/A	N/A	Shielded, 1.8m	N/A
14.	Notebook PC (Remote)	365	TZ30518	DoC	Acer	Unshielded, 20m	N/A

(FOR all test except EN 55022)

No.	Equipment	Model #	Serial #	FCC ID	Trade Name	Data Cable	Power Cord
1.	Monitor	D2835	KR74011499	A3LCGE750	HP	Shielded, 1.8m	Unshielded, 1.8m
2.	Modem	FM-144VR/1	93-503-27955	DK4FM144VR1	GVC	Shielded, 1.8m	Unshielded, 1.8m
3.	Modem	FM-144VR/1	94-101-31404	DK4FM144VR1	GVC	Shielded, 1.8m	Unshielded, 1.8m
4.	Printer	C2642A	TH86J1M2CQ	B94C2642X	HP	Shielded, 1.8m	AC I/P: Unshielded, 0.9m DC O/P: Unshielded, 1.9m
5.	PS/2 Keyboard	SK-2502C	M99043551	FCC DoC	HP	Shielded, 1.8m	N/A
6.	USB Mouse	M-UA34	LTC73700526	DZL211087	HP	Shielded, 1.8m	N/A
7.	USB Mouse	M-UA34	LTC73700535	DZL211087	Logitech	Shielded, 1.8m	N/A
8.	COM Mouse	M-MM43	LZE94052791	DoC	Logitech	Shielded, 1.8m	N/A
9.	COM Mouse	M-MM43	LZE94052771	DoC	Logitech	Shielded, 1.8m	N/A
10.	PS/2 Mouse	M-S43	LZA93405343	DZL211106	Logitech	Shielded, 1.8m	N/A
11.	Walkman	YX-328	W2	N/A	YING-KO	Unshielded, 1.8m	N/A
12.	Multimedia Headset	SX-M	A5-4	N/A	TOKYO	Unshielded, 1.8m	N/A
13.	Speaker	P-9A	E3	N/A	N/A	Unshielded, 1.8m	N/A
14.	Notebook PC (Remote)	365	TZ30518	DoC	Acer	Unshielded, 20m	N/A

Note: All the above equipment/cables were placed in worse case positions to maximize emission signals during emission test.

Grounding: Grounding was in accordance with the manufacturer's requirements and conditions for the intended use.

TEST FACILITY

- Location:** No. 15, 14 Line, Chin Twu Chi, Lu Chu Hsiang, Taoyuan, Taiwan, R.O.C.
- Description:** There are four 3/10m open area test sites and three line conducted labs for final test. The Open Area Test Sites and the Line Conducted labs are constructed and calibrated to meet the FCC requirements in documents ANSI C63.4: 1992 and CISPR 22/EN 55022 requirements.
- Site Filing:** A site description is on file with the Federal Communications Commission, 7435 Oakland Mills Road, Columbia, MD 21046.
- Registration also was made with Voluntary Control Council for Interference (VCCI).
- Site Accreditation:** Accredited by NEMKO (Authorization #: ELA 124) for EMC & A2LA (Certificate #: 824.01) for Emission
- Also accredited by BSMI for the product category of Information Technology Equipment.
- Instrument Tolerance:** All measuring equipment is in accord with ANSI C63.4 and CISPR 22 requirements that meet industry regulatory agency and accreditation agency requirement.
- Ground Plane:** Two conductive reference ground planes were used during the Line Conducted Emission, one in vertical and the other in horizontal. The dimensions of these ground planes are as below. The vertical ground plane was placed distancing 40 cm to the rear of the wooden test table on where the EUT and the support equipment were placed during test. The horizontal ground plane projected 50 cm beyond the footprint of the EUT system and distanced 80 cm to the wooden test table. For Radiated Emission Test, one horizontal conductive ground plane extended at least 1m beyond the periphery of the EUT and the largest measuring antenna, and covered the entire area between the EUT and the antenna. It has no holes or gaps having longitudinal dimensions larger than one-tenth of a wavelength at the highest frequency of measurement up to 1GHz.
- Site # 1 & # 3 Line Conducted Test Site:** Vertical ground plane (2.2m x 2.2m)
Horizontal ground plane (2.5m x 2.5m)
- Site # 4 Line Conducted Test Site:** At Shielding Room

TEST EQUIPMENT LIST

Instrumentation: The following list contains equipment used at C & C Laboratory, Co., Ltd. for testing. The equipment conforms to the CISPR 16-1 / ANSI C63.2-1988 Specifications for Electromagnetic Interference and Field Strength Instrumentation from 10kHz to 1.0 / 2.0 GHz.

Equipment used during the tests:

Open Area Test Site: ☐ # 1; ☐ # 2; ☐ # 3; ☒ # 4

Open Area Test Site # 1					
EQUIPMENT TYPE	* MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL. DUE
Spectrum Analyzer	ADVANTEST	R3261A	N/A	03/08/2000	03/07/2001
EMI Test Receiver	R&S	ESCS30	847793/012	11/06/1999	11/05/2000
PRE-AMP.	HP	8447F	2944A03748	10/22/1999	10/21/2000
Precision Dipole	R&S	HZ-12	846932/0004	07/14/2000	07/13/2001
Precision Dipole	R&S	HZ-13	846556/0008	07/14/2000	07/13/2001
Bilog Antenna	CHASE	CBL6112A	2309	02/13/2000	02/12/2001
Turn Table	EMCO	2081-1.21	N/A	N.C.R	N.C.R
Antenna Tower	EMCO	2075-2	9707-2604	N.C.R	N.C.R
Controller	EMCO	2090	N/A	N.C.R	N.C.R
RF Switch	ANRITSU	MP59B	N/A	N.C.R	N.C.R
Site NSA	C&C	N/A	N/A	11/10/1999	11/09/2000

Open Area Test Site # 2					
EQUIPMENT TYPE	MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL. DUE
Spectrum Analyzer	ADVANTEST	R3261C	81720301	09/02/1999	09/01/2000
Pre-Amplifier	HP	8447D	2944A08432	11/16/1999	11/15/2000
EMI Test Receiver	R&S	ESVS10	834468/006	03/24/2000	03/23/2001
Precision Dipole	R&S	HZ-12	846932/0004	07/14/2000	07/13/2001
Precision Dipole	R&S	HZ-13	846556/0008	07/14/2000	07/13/2001
Bilog Antenna	CHASE	CBL 6112A	SITE2	12/10/1999	12/09/2000
Turn Table	Chance Most	CM-T003-1	T807-6	N.C.R	N.C.R
Antenna Tower	Chance Most	CM-A003-1	A807-6	N.C.R	N.C.R
Controller	Chance Most	N/A	N/A	N.C.R	N.C.R
RF Switch	ANRITSU	MP59B	M76890	N.C.R	N.C.R
Site NSA	C&C Lab.	N/A	N/A	11/13/1999	11/12/2000

Open Area Test Site # 3					
EQUIPMENT TYPE	* MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL. DUE
Spectrum Analyzer	ADVANTEST	R3261C	71720533	10/25/1999	10/24/2000
Pre-Amplifier	HP	8447D	2944A09173	02/01/2000	01/31/2001
EMI Test Receiver	R&S	ESVS20	838804/004	12/24/1999	12/23/2000
Precision Dipole	R&S	HZ-12	846932/0004	07/14/2000	07/13/2001
Precision Dipole	R&S	HZ-13	846556/0008	07/14/2000	07/13/2001
Bilog Antenna	CHASE	CBL6112A	2179	11/27/1999	11/26/2000
Turn Table	EMCO	2081-1.21	9709-1885	N.C.R	N.C.R
Antenna Tower	EMCO	2075-2	9707-2060	N.C.R	N.C.R
Controller	EMCO	2090	9709-1256	N.C.R	N.C.R
RF Switch	ANRITSU	MP59B	N/A	N.C.R	N.C.R
Site NSA	C&C	N/A	N/A	01/30/2000	01/30/2001

Open Area Test Site # 4					
EQUIPMENT TYPE	* MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL. DUE
Spectrum Analyzer	ADVANTEST	R3132	91700456	02/15/2000	02/14/2001
Pre-Amplifier	HP	8447F	2944A03748	10/22/1999	10/21/2000
EMI Test Receiver	R&S	ESVS10	846285/016	12/17/1999	12/16/2000
Precision Dipole	R&S	HZ-12	846932/0004	07/14/2000	07/13/2001
Precision Dipole	R&S	HZ-13	846556/0008	07/14/2000	07/13/2001
Bilog Antenna	CHASE	CBL 6112B	2462	01/13/2000	01/12/2001
Turn Table	Chance most	N/A	N/A	N.C.R	N.C.R
Antenna Tower	Chance most	N/A	N/A	N.C.R	N.C.R
Controller	Chance most	N/A	N/A	N.C.R	N.C.R
RF Switch	ANRITSU	MP59B	N/A	N.C.R	N.C.R
Site NSA	C&C Lab.	N/A	N/A	12/26/1999	12/25/2000

Conducted Emission Test Site:

Conducted Emission Test Site # 4					
EQUIPMENT TYPE	MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL. DUE
EMI Test Receiver	R&S	ESHS10	843743/015	12/10/1999	12/09/2000
LISN	EMCO	3825/2	9003/1382	01/10/2000	01/09/2001
LISN	R&S	ESH2-Z5	843250/010	12/06/1999	12/05/2000

The calibrations of the measuring instruments, including any accessories that may effect such calibration, are checked frequently to assure their accuracy. Adjustments are made and correction factors applied in accordance with instructions contained in the manual for the measuring instrument.

TEST EQUIPMENT LIST

For Power Harmonic & Voltage Fluctuation/Flicker Measurement:

Manufacturer/Type	Model No.	Serial No.	Last Cal.	Cal. Due
HAEFELY TRENCH Harmonic & Flicker Tester	PHF 555	080 419-25	Oct. 05, 1999	Oct.05, 2000

For ESD test:

Manufacturer/Type	Model No.	Serial No.	Last Cal.	Cal. Due
EMV SYSTEME/ ESD Generator	SESD 2000	812006	Nov. 19, 1999	Nov. 18, 2000

For Radiated Electromagnetic Field immunity Measurement:

Manufacturer/Type	Model No.	Serial No.	Last Cal.	Cal. Due
Maconi /Signal Generator	2022D	119246/003	Aug. 17, 1999	Aug. 16, 2000
M2S / Power Amplifier	A00181/1000	9801-112	N/A	N/A
M2S / Power Amplifier	AC8113/800-250A	9801-179	N/A	N/A
Wandel & Goltormann/ EM-Radiation Meter	EMR-30	L-0013	02/25/2000	02/24/2001
EMCO Power Antenna	3141	9712-1083	N/A	N/A

For Fast Transients/Burst test:

Manufacturer/Type	Model No.	Serial No.	Last Cal.	Cal. Due
HAEFELY TRENCH/ Fast Transients/Burst Generator	PEFT-JUNIOR	583 333-117	Aug. 18, 1999	Aug. 18, 2000

For CS test:

Manufacturer/Type	Model No.	Serial No.	Last Cal.	Cal. Due
Maconi /Signal Generator	2022D	119246/003	Aug. 17, 1999	Aug. 16, 2000
MEB / CDN M3	M3	3683	Sep. 09, 1999	Sep. 08, 2000
M2S / Power Amplifier	A00181/1000	9801-112	N/A	N/A

SECTION 1 EN 55022 (LINE CONDUCTED & RADIATED EMISSION)

MEASUREMENT PROCEDURE (PRELIMINARY LINE CONDUCTED EMISSION TEST)

- 1) The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per EN 55022 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- 2) Support equipment, if needed, was placed as per EN 55022.
- 3) All I/O cables were positioned to simulate typical actual usage as per EN 55022.
- 4) The EUT received AC power through a Line Impedance Stabilization Network (LISN) which supplied power source of 230VAC/50Hz and was grounded to the ground plane.
- 5) All support equipment received power from a second LISN supplying power of 110VAC/60Hz.
- 6) The EUT test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum Analyzer / Receiver connected to the LISN powering the EUT. The LISN has two monitoring points: Line 1 (Hot Side) and Line 2 (Neutral Side). Two scans were taken: one with Line 1 connected to Analyzer / Receiver and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.
- 7) Analyzer / Receiver scanned from 150kHz to 30MHz for emissions in each of the test modes.
- 8) During the above scans, the emissions were maximized by cable manipulation.
- 9) The following test mode were scanned during the preliminary test:
Mode: (Customer defined)
 1. 1024 x 768 with MMX-266MHz CPU
 2. 800 x 600 with MMX-266MHz CPU
 3. 640 x 480 with MMX-266MHz CPU

- 10) After the preliminary scan, we found the following test mode producing the highest emission level.

Mode: 1.

Then, the EUT configuration and cable configuration of the above highest emission level were recorded for reference of final testing.

MEASUREMENT PROCEDURE (FINAL LINE CONDUCTED EMISSION TEST)

- 1) EUT and support equipment was set up on the test bench as per step 10 of the preliminary test.
- 2) A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit.
- 3) The test data of the worst case condition(s) was reported on the Summary Data page.

Data Sample:

Freq. MHz	Q.P. Raw dBuV	Average Raw dBuV	Q.P. Limit dBuV	Average Limit dBuV	Q.P. Margin dB	Average Margin dB	Note
x.xx	43.95	---	56	46	-12.05	-2.05	L 1

Freq.	= Emission frequency in MHz
Raw dBuV	= Uncorrected Analyzer/Receiver reading
Limit dBuV	= Limit stated in standard
Margin dB	= Reading in reference to limit
Note	= Current carrying line of reading
“---”	= The emission level complied with the Average limits, with at least 2 dB margin, so no further recheck.

LINE CONDUCTED EMISSION LIMIT

Frequency	Maximum RF Line Voltage	
	Q.P.	AVERAGE
150kHz-500kHz	79dBuV	66dBuV
500kHz-5MHz	73dBuV	60dBuV
5MHz-30MHz	73dBuV	60dBuV

Note: The lower limit shall apply at the transition frequency.

MEASUREMENT PROCEDURE (PRELIMINARY RADIATED EMISSION TEST)

- 1) The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane as per EN 55022 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- 2) Support equipment, if needed, was placed as per EN 55022.
- 3) All I/O cables were positioned to simulate typical actual usage as per EN 55022.
- 4) The EUT received 230VAC/50Hz power source from the outlet socket under the turntable. All support equipment received 110VAC/60Hz power from another socket under the turntable.
- 5) The antenna was placed at some given distance away from the EUT as stated in EN 55022: 1994. The antenna connected to the analyzer via a cable and at times a pre-amplifier would be used.
- 6) The Analyzer quickly scanned from 30MHz to 1000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- 7) The following test mode were scanned during the preliminary test:

Mode: (Customer defined)

1. 1024 x 768 with MMX-266MHz CPU
2. 800 x 600 with MMX-266MHz CPU
3. 640 x 480 with MMX-266MHz CPU

- 8) After the preliminary scan, we found the following test mode producing the highest emission level.

Mode: 1.

Then, the EUT and cable configuration, antenna position, polarization and turntable position of the above highest emission level were recorded for final testing.

MEASUREMENT PROCEDURE (FINAL RADIATED EMISSION TEST)

- 1) EUT and support equipment were set up on the turntable as per step 8 of the preliminary test.
- 2) The Analyzer / Receiver scanned from 30MHz to 1000MHz. Emissions were scanned and measured rotating the EUT to 360 degrees, varying cable placement and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- 3) Recorded at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and only Q.P. reading is presented.
- 4) The test data of the worst case condition(s) was reported on the Summary Data page.

Data Sample:

Freq. (MHz)	Raw Data (dBuV/m)	Corr. Factor (dB)	Emiss. Level (dBuV/m)	Limits	Margin (dB)
xx.xx	14.0	11.2	26.2	30	-3.8

Freq.	= Emission frequency in MHz
Raw Data (dBuV/m)	= Uncorrected Analyzer / Receiver reading
Corr. Factor (dB)	= Correction factors of antenna factor and cable loss
Emiss. Level	= Raw reading converted to dBuV and CF added
Limit dBuV/m	= Limit stated in standard
Margin dB	= Reading in reference to limit

RADIATED EMISSION LIMIT

Frequency (MHz)	Distance (m)	Maximum Field Strength Limit (dBuV/m/ Q.P.)
30-230	10	40
230-1000	10	47

Note: The lower limit shall apply at the transition frequency.

BLOCK DIAGRAM OF TEST SETUP (FOR EN 55022 test only)

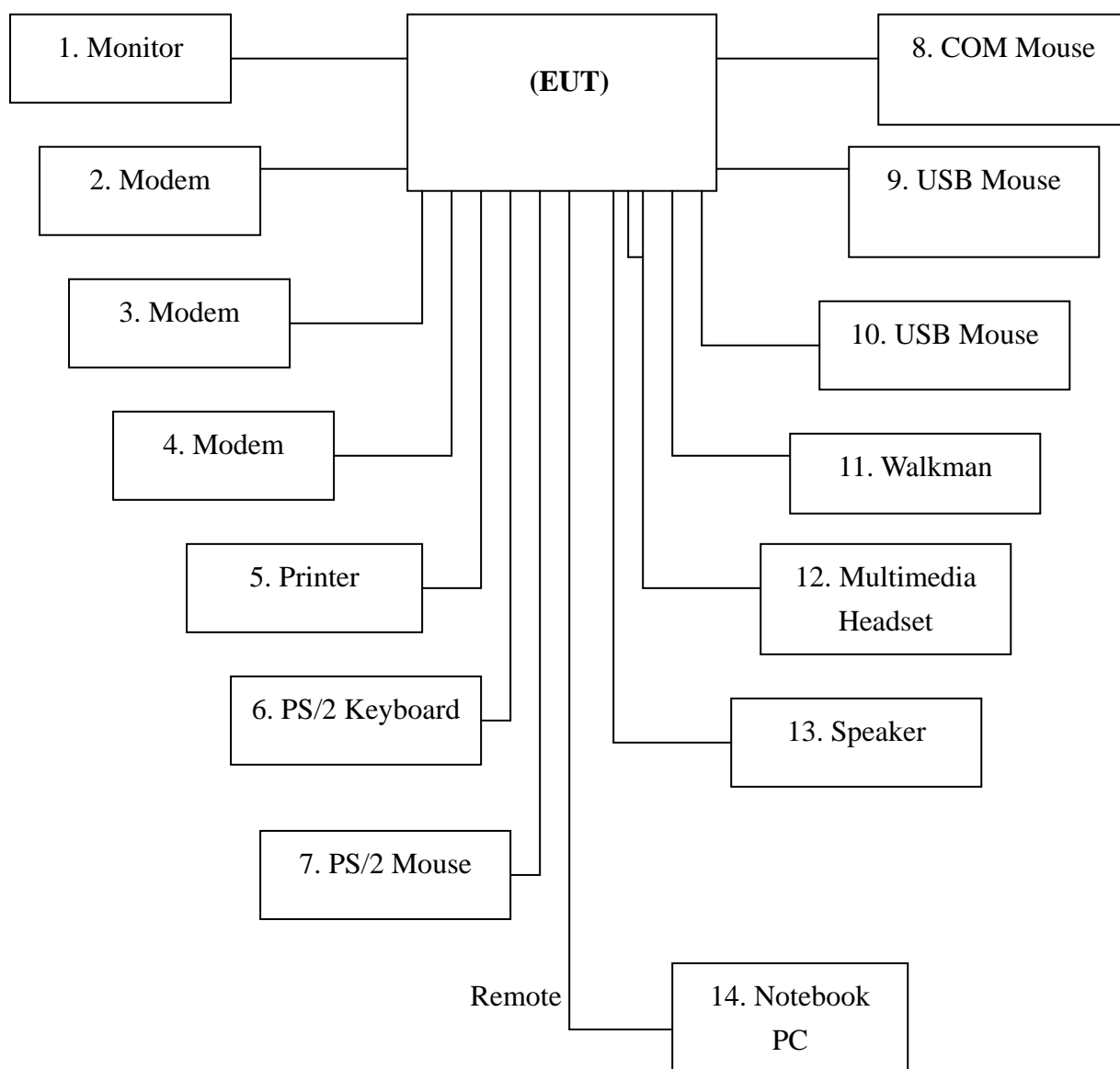
SYSTEM DIAGRAM OF CONNECTIONS BETWEEN EUT AND SIMULATORS

EUT: PENTIUM EBX SBC

Trade Name: ADVANTECH

Model Number: PCM-9550F-F0A1

AC Power Cord: Unshielded, 1.8m (Detachable)



BLOCK DIAGRAM OF TEST SETUP (FOR all test except EN 55022)

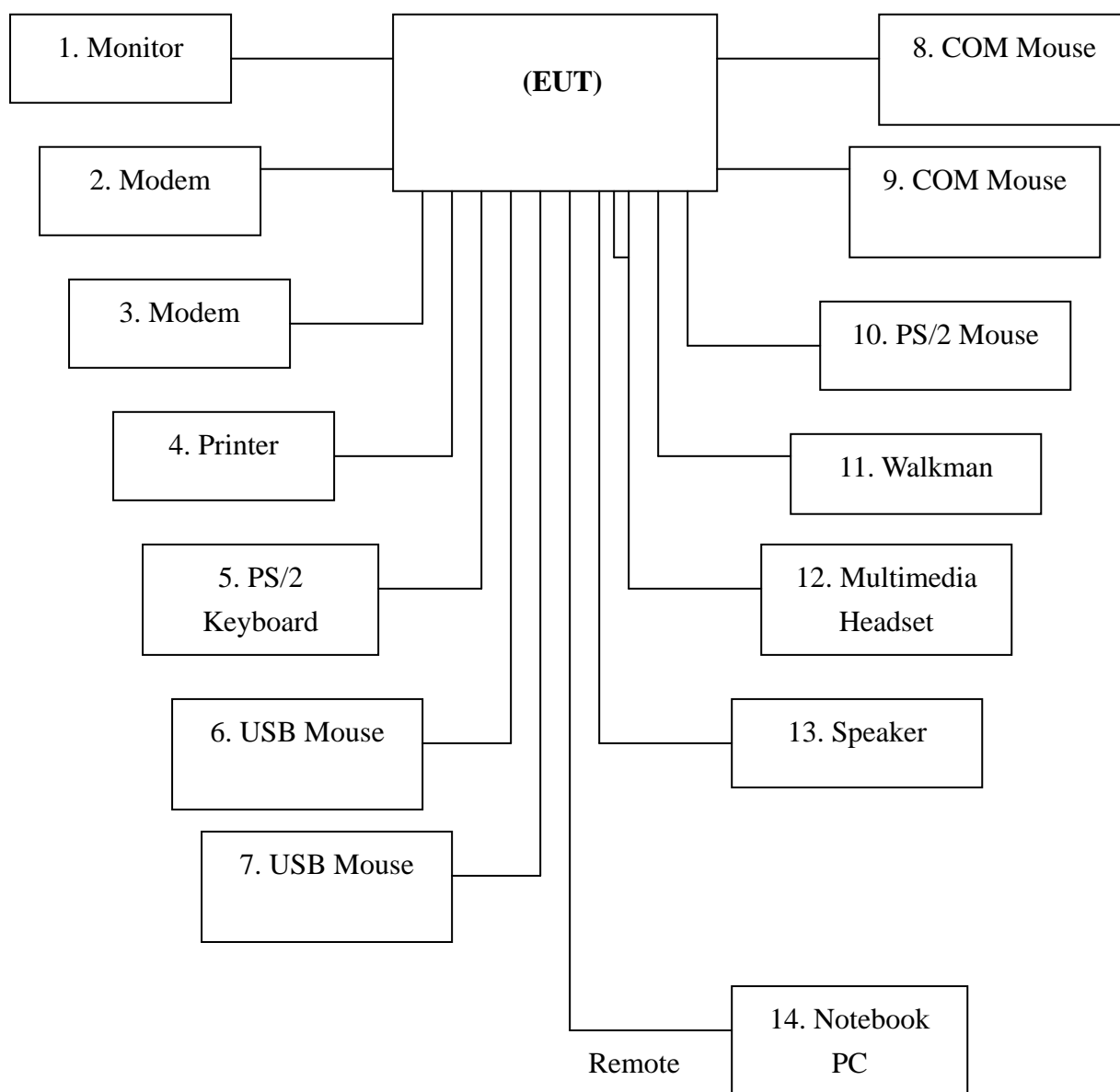
SYSTEM DIAGRAM OF CONNECTIONS BETWEEN EUT AND SIMULATORS

EUT: PENTIUM EBX SBC

Trade Name: ADVANTECH

Model Number: PCM-9550F-F0A1

AC Power Cord: Unshielded, 1.8m (Detachable)



SUMMARY DATA

(LINE CONDUCTED TEST)

Model Number: PCM-9550F-F0A1

Location: Site # 4

Tested by: Tony Tsai

Test Mode: Mode 1

Test Results: Passed

Temperature: 28C

Humidity: 63%RH

(The chart below shows the highest readings taken from the final data)

FREQ MHz	Q.P. RAW dBuV	AVG RAW dBuV	Q.P. Limit dBuV	AVG Limit dBuV	Q.P. Margin dB	AVG Margin dB	NOTE
0.200	41.2	---	79.0	66.0	-37.8	---	L1
5.150	34.4	---	73.0	60.0	-38.6	---	L1
12.640	41.1	---	73.0	60.0	-31.9	---	L1
13.110	40.7	---	73.0	60.0	-32.3	---	L1
15.720	40.6	---	73.0	60.0	-32.4	---	L1
16.320	40.8	---	73.0	60.0	-32.2	---	L1
0.150	40.1	---	79.0	66.0	-38.9	---	L2
10.830	37.7	---	73.0	60.0	-35.3	---	L2
16.170	33.3	---	73.0	60.0	-39.7	---	L2
16.240	38.9	---	73.0	60.0	-34.1	---	L2
21.660	41.8	---	73.0	60.0	-31.2	---	L2
27.070	36.5	---	73.0	60.0	-36.5	---	L2

L1 = Line One (Hot side) / L2 = Line Two (Neutral side)

****NOTE: “---” denotes the emission level was or more than 2dB below the Average limit, so no re-check anymore.**

SUMMARY DATA

(RADIATED EMISSION TEST)

Model Number: PCM-9550F-F0A1

Location: Site # 4

Tested by: Michael Chen

Test Mode: Mode 1

Polar: Vertical -- 10m

Detector Function: Quasi-Peak

Test Results: Passed

Temperature: 32⁰C

Humidity: 70%RH

(The chart below shows the highest readings taken from the final data)

Freq. (MHz)	Raw Data (dBuV/m)	Corr. Factor (dB)	Emiss. Level (dBuV/m)	Limits	Margin (dB)
57.28	18.5	6.2	24.7	40.0	-15.3
66.66	22.3	5.3	27.6	40.0	-12.4
78.58	29.9	6.3	36.2	40.0	-3.8
133.66	10.8	12.7	23.5	40.0	-16.5
267.17	11.6	14.0	25.6	47.0	-21.4
435.66	8.2	19.4	27.6	47.0	-19.4

SUMMARY DATA

(RADIATED EMISSION TEST)

Model Number: PCM-9550F-F0A1

Location: Site # 4

Tested by: Michael Chen

Test Mode: Mode 1

Polar: Horizontal -- 10m

Detector Function: Quasi-Peak

Test Results: Passed

Temperature: 32°C

Humidity: 70%RH

(The chart below shows the highest readings taken from the final data)

Freq. (MHz)	Raw Data (dBuV/m)	Corr. Factor (dB)	Emiss. Level (dBuV/m)	Limits	Margin (dB)
57.37	13.9	6.2	20.1	40.0	-19.9
66.09	16.1	5.3	21.4	40.0	-18.6
78.76	22.7	6.3	29.0	40.0	-11.0
133.73	8.9	12.7	21.6	40.0	-18.4
269.44	6.4	14.1	20.5	47.0	-26.5
433.05	11.3	19.4	30.7	47.0	-16.3

SECTION 2 EN 61000-3-2 & EN 61000-3-3 (POWER HARMONICS & VOLTAGE FLUCTUATION/FLICKER)

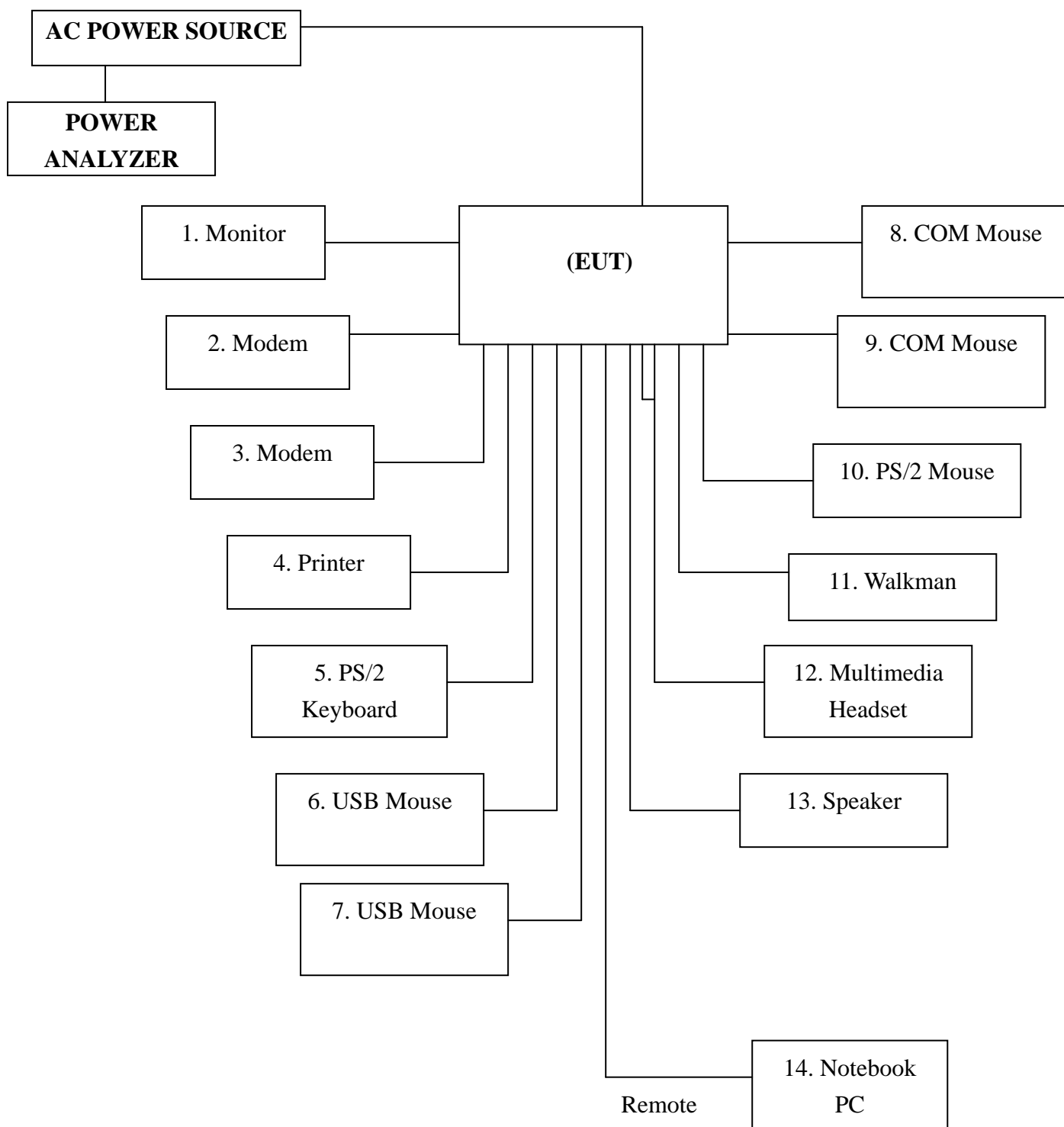
POWER HARMONICS MEASUREMENT (FOR EN 55022 test only)

Port : AC mains
Basic Standard : EN 61000-3-2: 1995 +A1: 1998 + A2: 1998
Limits : ☒ Class A, ☐ Class D
Temperature : 29⁰C
Humidity : 42%
Test By : Kevin Wang

VOLTAGE FLUCTUATION/FLICKER MEASUREMENT

Port : AC mains
Basic Standard : EN 61000-3-3 (1995)
Limits : §5 of EN 61000-3-3
Temperature : 29⁰C
Humidity : 42%
Test By : Kevin Wang

Block Diagram of Test Setup:



Result:

Please see the attached test data.

EN 61000-3-2 TEST REPORT 2000/6/27 10:26 AM

Unit: PENTIUM EBX SBC

Serial No.: PCM-9550F-F0A1

Remarks: Temp: 29°C Humidity: 42%

Operator: KEVIN

=====

TEST SETUP

Test Freq.:	50.00 Hz.	Test Voltage:	100.0 vac
Waveform :	SINE	Test Time:	2.5 min.
Classification :	CLASS A	Test Type:	STEADY-STATE

Prog. Zo Enabled:	YES	Prog. Zo:	0.000
-------------------	-----	-----------	-------

Motor Driven with Phase Angle Control:	NO
Impedance selected:	DIRECT

Synthetic R+L Enabled:	NO
Resistance: 0.380 Ohms	Inductance: 460.000 uH

Max Watts: 27.0W

TEST DATA

Result: PASS

Harmonic Current Results

Hn	AMPS	LO Limit	HI Limit	Result
0	0.000	0.000	0.000	PASS
1	0.274	NaN	NaN	PASS
2	0.003	1.080	1.080	PASS
3	0.261	2.300	2.300	PASS
4	0.002	0.430	0.430	PASS
5	0.227	1.140	1.140	PASS
6	0.002	0.300	0.300	PASS
7	0.186	0.770	0.770	PASS
8	0.002	0.230	0.230	PASS
9	0.142	0.400	0.400	PASS
10	0.002	0.184	0.184	PASS
11	0.100	0.330	0.330	PASS
12	0.002	0.153	0.153	PASS
13	0.065	0.210	0.210	PASS
14	0.002	0.131	0.131	PASS
15	0.043	0.150	0.150	PASS
16	0.002	0.115	0.115	PASS
17	0.035	0.132	0.132	PASS
18	0.002	0.102	0.102	PASS
19	0.033	0.118	0.118	PASS
20	0.002	0.092	0.092	PASS
21	0.029	0.107	0.107	PASS

22	0.002	0.084	0.084	PASS
23	0.023	0.098	0.098	PASS
24	0.001	0.077	0.077	PASS
25	0.016	0.090	0.090	PASS
26	0.001	0.071	0.071	PASS
27	0.010	0.083	0.083	PASS
28	0.001	0.066	0.066	PASS
29	0.006	0.078	0.078	PASS
30	0.001	0.061	0.061	PASS
31	0.006	0.073	0.073	PASS
32	0.001	0.058	0.058	PASS
33	0.006	0.068	0.068	PASS
34	0.000	0.054	0.054	PASS
35	0.006	0.064	0.064	PASS
36	0.000	0.051	0.051	PASS
37	0.005	0.061	0.061	PASS
38	0.000	0.048	0.048	PASS
39	0.004	0.058	0.058	PASS
40	0.001	0.046	0.046	PASS

END OF REPORT

EN 61000-3-3 TEST REPORT 2000/6/27 10:40 AM

Unit: PENTIUM EBX SBC

Serial No.: PCM-9550F-F0A1

Remarks: Temp: 29°C Humidity: 42%

Operator: KEVIN

=====

TEST SETUP

Test Freq.: 50.00 Hz. Test Voltage: 100.0 vac

Waveform : SINE

Test Time: 10.0 min. Tshort: 10.0 min.

Prog. Zo Enabled: YES Prog. Zo: 0.000

Voltage Change less than once per Hour: NO

Impedance selected: DIRECT

Synthetic R+L Enabled: NO

Resistance: 0.380 Ohms Inductance: 460.000 uH

TEST DATA

Result: PASS

	EUT Data	Limit	Result	Test Enabled
Pst max	0.001	1.00	PASS	true
Plt max	0.001	0.65	PASS	true
dc %	0.00	3.00	PASS	true
dmax %	0.00	4.00	PASS	true
d(t) sec.	0.00	0.20	PASS	true

Power Source Data

Source Pst max	0.009	0.400	PASS	true
% THD	0.05	3.00	PASS	true

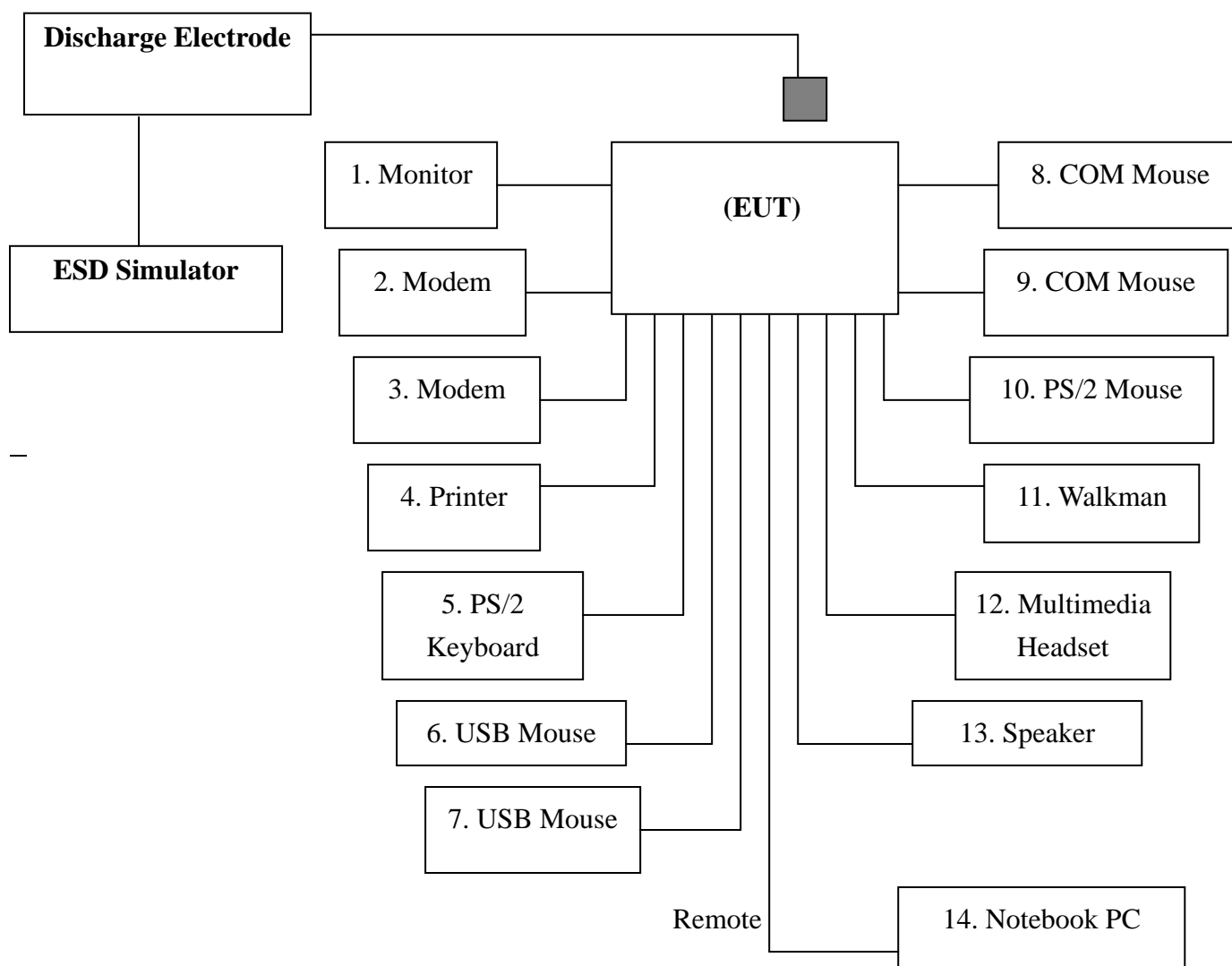
END OF REPORT

SECTION 3 EN 61000-4-2 (ELECTROSTATIC DISCHARGE)

ELECTROSTATIC DISCHARGE (ESD) IMMUNITY TEST

Port : Enclosure
Basic Standard : EN 61000-4-2
Requirements : $\pm 8\text{kV}$ (Air Discharge)
 $\pm 4\text{kV}$ (Contact Discharge)
 $\pm 4\text{kV}$ (Indirect Discharge)
Performance Criteria : A (Standard Required)
Temperature/Humidity: 24°C / 48%
Test By : Kevin Wang

Block Diagram of Test Setup:



Test Procedure:

The electrostatic discharges were applied as follows:

Amount of Discharges	Voltage	Coupling	Result (Pass/Fail)
≥ 10 Point	$\pm 8\text{kV}$	Air Discharge	Pass
≥ 10 /Point	$\pm 4\text{kV}$	Contact Discharge	Pass
≥ 10 /Point	$\pm 4\text{kV}$	Indirect Discharge HCP (Front)	Pass
≥ 10 /Point	$\pm 4\text{kV}$	Indirect Discharge HCP (Left)	Pass
≥ 10 /Point	$\pm 4\text{kV}$	Indirect Discharge HCP (Back)	Pass
≥ 10 /Point	$\pm 4\text{kV}$	Indirect Discharge HCP (Right)	Pass
≥ 10 /Point	$\pm 4\text{kV}$	Indirect Discharge VCP (Front)	Pass
≥ 10 /Point	$\pm 4\text{kV}$	Indirect Discharge VCP (Left)	Pass
≥ 10 /Point	$\pm 4\text{kV}$	Indirect Discharge VCP (Back)	Pass
≥ 10 /Point	$\pm 4\text{kV}$	Indirect Discharge VCP (Right)	Pass

**** The tested points to EUT, please refer to attached pages.**

Performance & Result:

- ☒ **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

****Observation:** No any function degraded during the tests.

The Tested Points of EUT



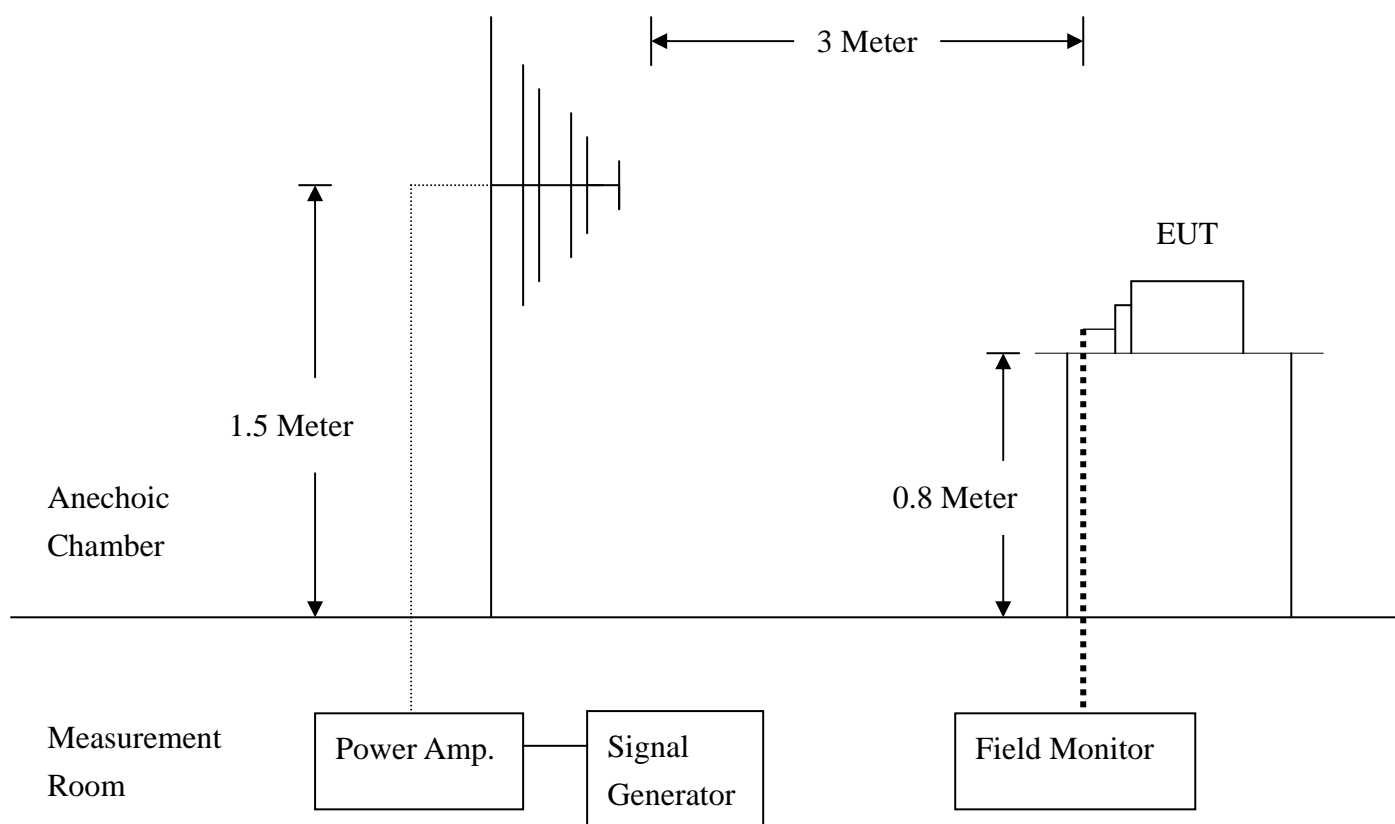
SECTION 4 ENV 50140 (RADIATED ELECTROMAGNETIC FIELD)

RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST

Port : Enclosure
Basic Standard : ENV 50140
Requirements : 10 V/m, with Modulated
Performance Criteria : A (Standard Required)
Temperature : 26⁰C
Humidity : 53%
Test By : Peter Lee

Block Diagram of Test Setup:

Same as Section 3 EN61000-4-2 Test Setup:



Test Procedure:

Frequency Range : 80MHz-1000MHz

Frequency Step : 1% of fundamental

Dwell Time : 3 sec

Range (MHz)	Field	Modulation	Polarity	Position (°)	Result (Pass/Fail)
80-1000	10V	Yes	H	0	Pass
80-1000	10V	Yes	V	0	Pass
80-1000	10V	Yes	H	90	Pass
80-1000	10V	Yes	V	90	Pass
80-1000	10V	Yes	H	180	Pass
80-1000	10V	Yes	V	180	Pass
80-1000	10V	Yes	H	270	Pass
80-1000	10V	Yes	V	270	Pass

Performance & Result:

- ☒ **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

****Observation:** No any function degraded during the tests.

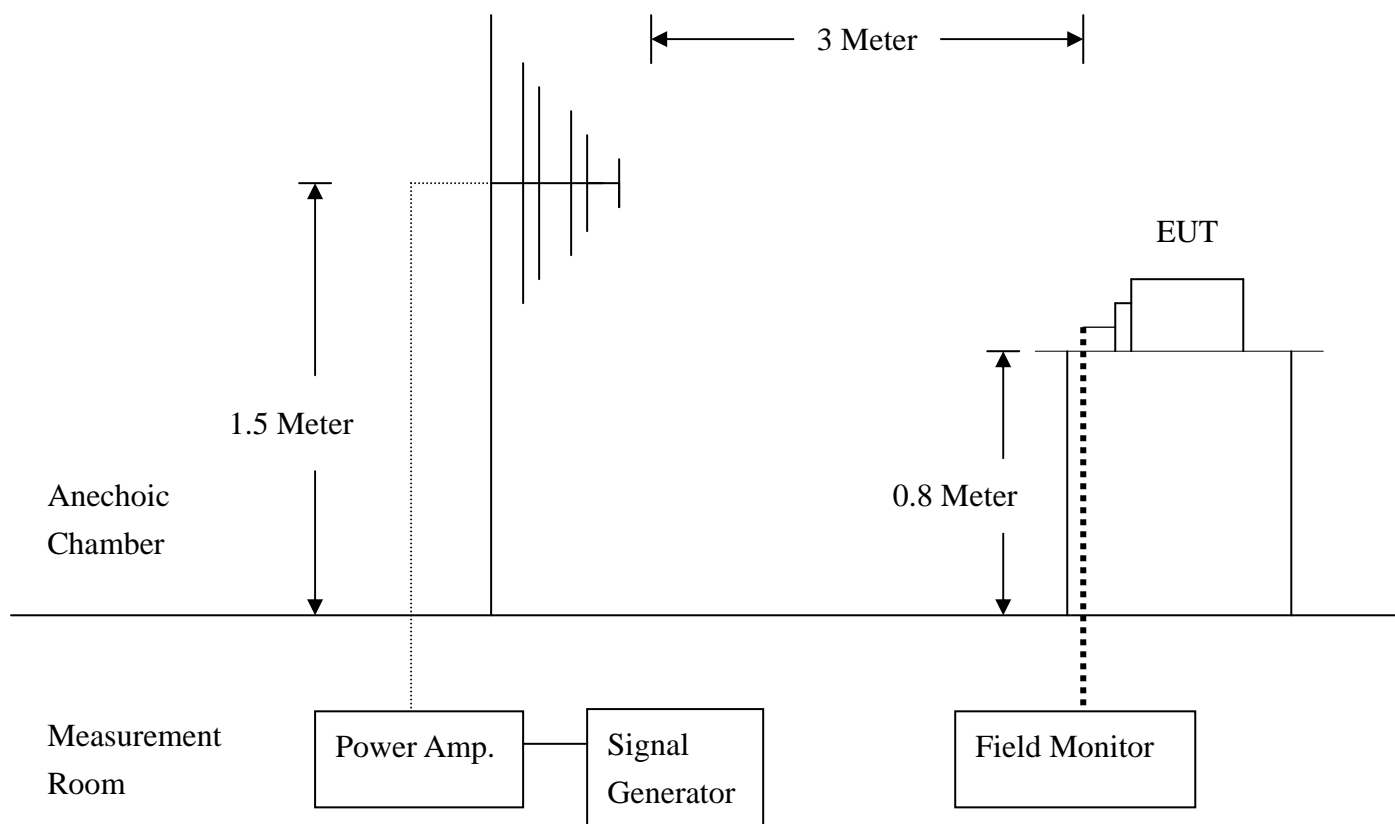
SECTION 5 ENV 50204 (RADIATED ELECTROMAGNETIC FIELD FROM DIGITAL TELEPHONES)

RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST

Port : Enclosure
Basic Standard : ENV 50204
Requirements : 10 V/m, with modulated
Performance Criteria : A (Standard Required)
Temperature : 26⁰C
Humidity : 53%
Test By : Peter Lee

Block Diagram of Test Setup:

Same as Section 3 EN61000-4-2 Test Setup:



Test Procedure:

Spot Frequency : 900 MHz \pm 5MHz

Modulated Frequency : 200 Hz

Duty cycle : 50%

Range (MHz)	Field	Modulation	Polarity	Position (°)	Result (Pass/Fail)
900	10V	Yes	H	0	Pass
900	10V	Yes	V	0	Pass
900	10V	Yes	H	90	Pass
900	10V	Yes	V	90	Pass
900	10V	Yes	H	180	Pass
900	10V	Yes	V	180	Pass
900	10V	Yes	H	270	Pass
900	10V	Yes	V	270	Pass

Performance & Result:

☒ **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.

☐ **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.

☐ **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

****Observation:** No any function degraded during the tests.

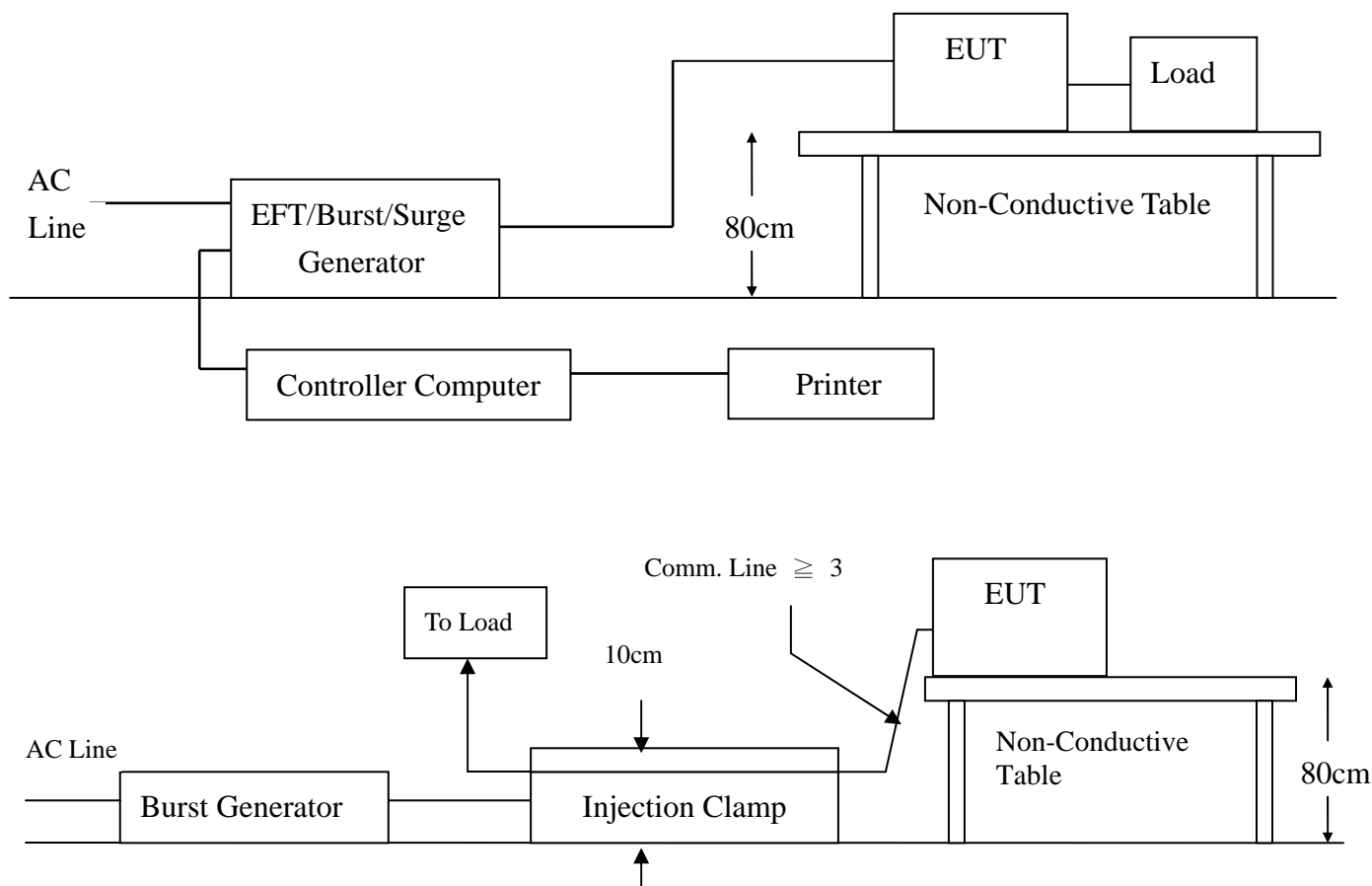
SECTION 6 EN 61000-4-4 (FAST TRANSIENTS/BURST)

FAST TRANSIENTS/BURST IMMUNITY TEST

Port	: On Power Port
Basic Standard	: EN 61000-4-4
Requirements	: $\pm 2\text{kV}$ for Power Supply Line $\pm 1\text{kV}$ to LAN Cable
Performance Criteria	: B (Standard require)
Temperature	: 30°C
Humidity	: 45%
Test By	: Kevin Wang

Block Diagram of Test Setup:

Same as Section 3 EN 61000-4-2 Test Setup:



Test Procedure:

Impulse Frequency: 5kHz

Tr/Th: 5/50ns

Burst Duration: 15ms

Burst Period: 3Hz

Inject Line	Voltage kV	Inject Method	Result (Pass/Fail)
L1	± 2	Direct	Pass
N	± 2	Direct	Pass
PE	± 2	Direct	Pass
L1 + N	± 2	Direct	Pass
L1 + PE	± 2	Direct	Pass
N + PE	± 2	Direct	Pass
L1 + N + PE	± 2	Direct	Pass
LAN Cable	± 1	Clamp	Pass

Performance & Result:

- ☒ **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

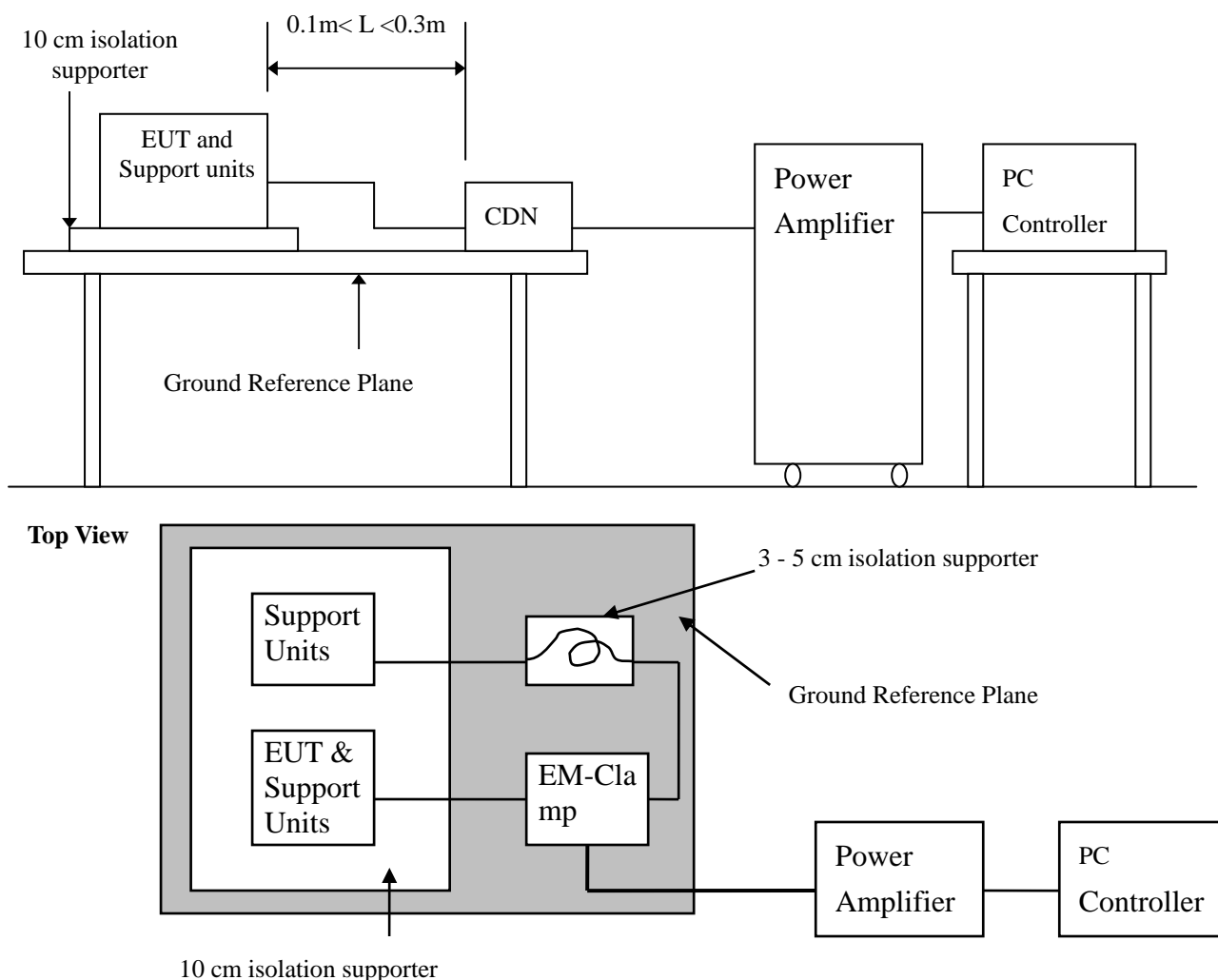
****Observation:** No any function degraded during the tests.

SECTION 7 ENV 50141 (CONDUCTED DISTURBANCE/INDUCED BY RADIO-FREQUENCY FIELD)

Port : Power cord and Data bus
Basic Standard : ENV 50141
Requirements : 10 V with Modulated
Injection Method : CDN-M3 for Power Supply
 EM-Clamp for LAN cable
Performance Criteria : A
Temperature : 26⁰C
Humidity : 53%
Test By : Peter Lee

Block Diagram of Test Setup:

Same as Section 3 EN 61000-4-2 Test Setup:



Test Procedure:

Frequency Range : 0.15MHz-80MHz

Frequency Step : 1% of fundamental

Dwell Time : 3 sec

Range (MHz)	Field	Modulation	Result (Pass/Fail)
0.15-80	10V	Yes	Pass

Performance & Result:

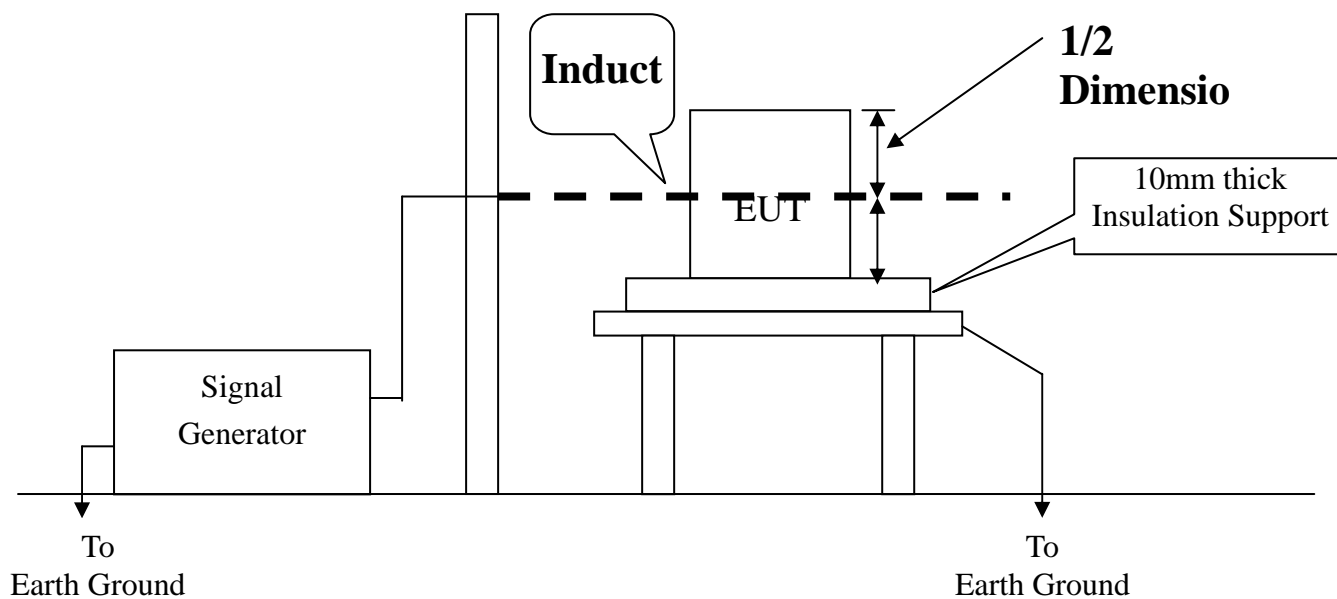
- ☒ **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

****Observation:** No any function degraded during the tests.

SECTION 8 EN 61000-4-8 (POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST)

Port : Enclosure
Basic Standard : EN 61000-4-8
Requirements : 3 A/m
Performance Criteria : A (Standard Required)
Temperature : N/A
Humidity : N/A

Block Diagram of Test Setup:



Test Procedure:

Field Strength: 3A/m
Power Freq.: 50Hz
Orientation: X, Y, Z

Orientation	Field	Result (Pass/Fail)	Remark

****Note:** Not applicable, because no any component can be influenced by power magnetic fields.

Performance & Result:

- ☐ **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

****Observation:** N/A

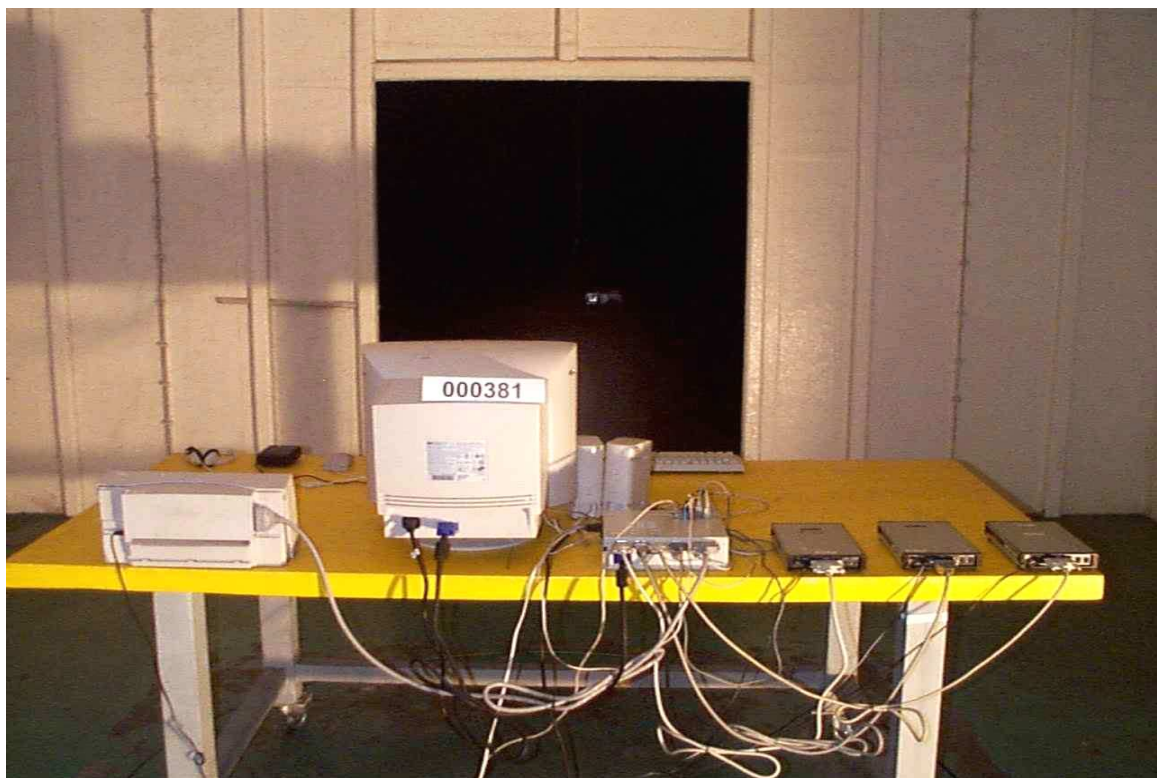
APPENDIX 1

PHOTOGRAPHS OF TEST SETUP

LINE CONDUCTED EMISSION TEST (EN 55022)



RADIATED EMISSION TEST (EN 55022)



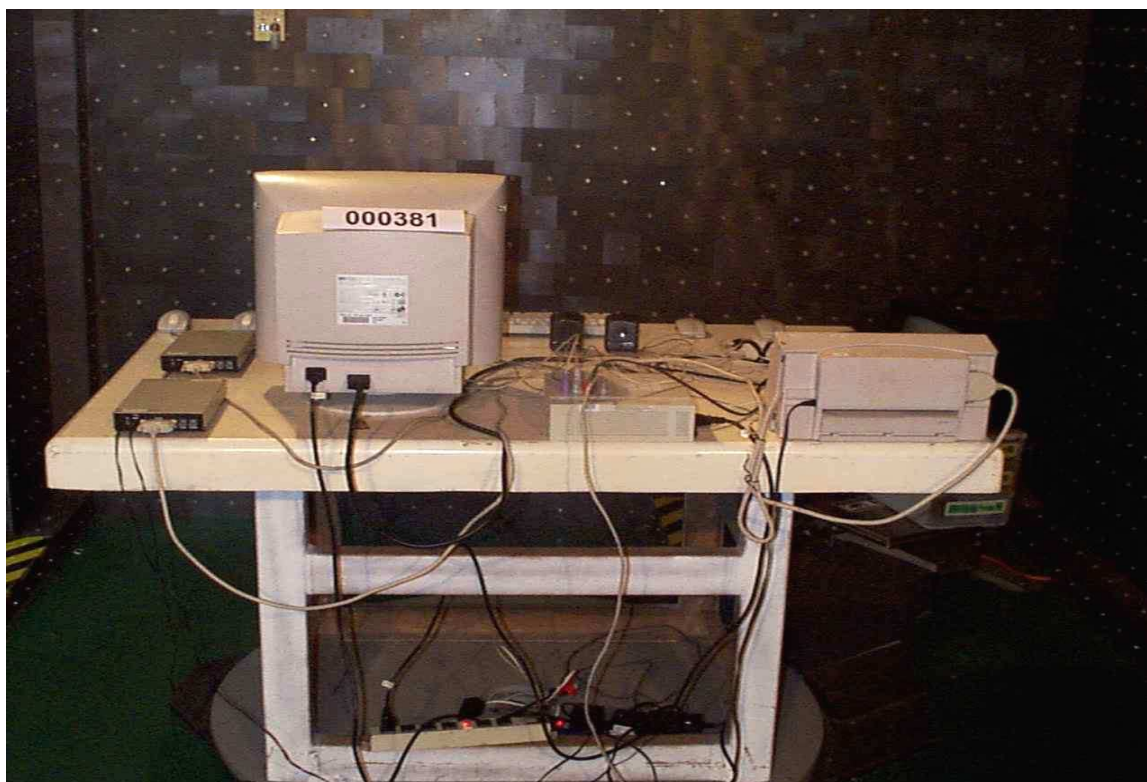
POWER HARMONIC & VOLTAGE FLUCTUATION / FLICKER TEST (EN 61000-3-2, EN 61000-3-3)



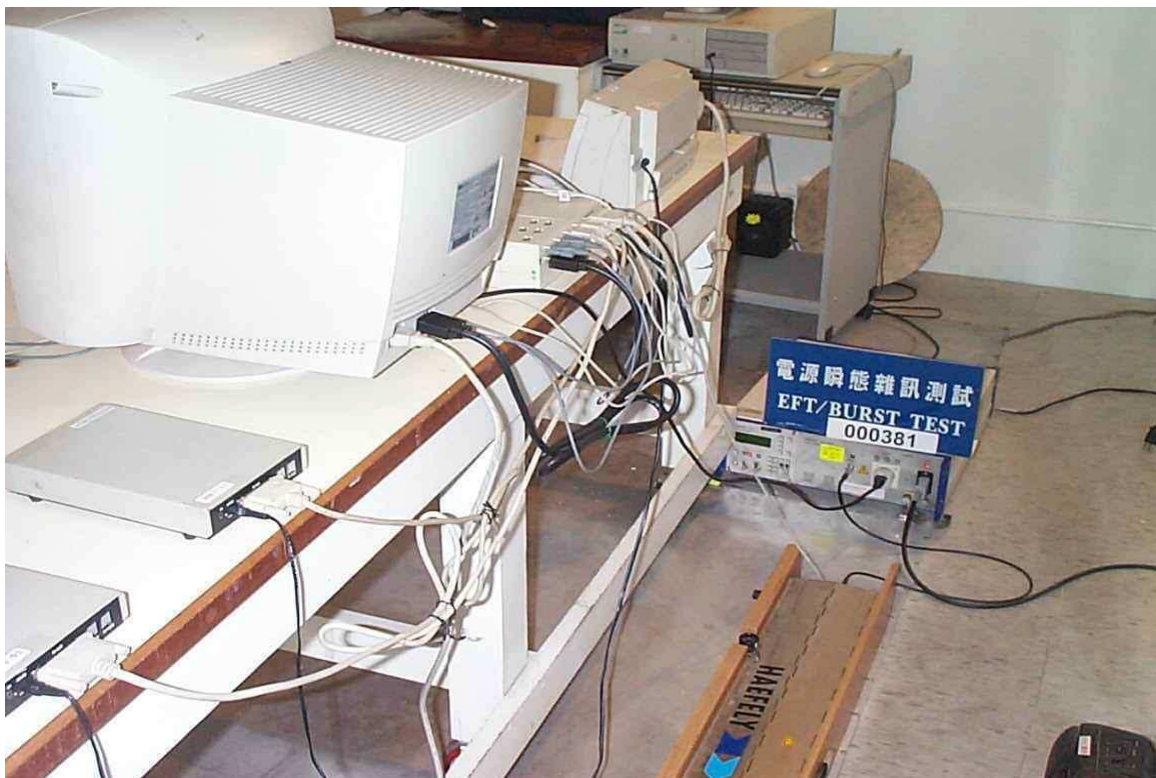
ELECTROSTATIC DISCHARGE TEST (EN 61000-4-2)



RADIATED ELECTROMAGNETIC FIELD (ENV 50140 & ENV 50204)



FAST TRANSIENTS/BURST TEST (EN 61000-4-4)



CONDUCTED DISTURBANCE, INDUCED BY RADIO-FREQUENCY FIELDS TEST (ENV 50141)



APPENDIX 2

PHOTOGRAPHS OF EUT

Front View of EUT



Rear View of EUT



Model: PCM-9550F-F0A1

